SML75HB06

Attributes:
-aerospace build standard
-high reliability
-lightweight
-metal matrix base plate
-AlN isolation

Maximum rated values/ Electrical Properties

Collector-emitter Voltage		V_{ces}	600	V
DC Collector Current	Tc=75C Tc=25C	I_c nom I_c	75 100	A
Repetitive peak Collector Current	tp=1msec,Tc=75C	I_{crm}	150	A
Total PowerDissipation	Tc=25C	P_{tot}	260	W
Gate-emitter peak voltage		V_{ges}	+/-20	V
DC Forward Diode Current		I_f	75	A
Repetitive Peak Forward Current	tp=1msec	I_{frm}	150	A
I^2t value per diode	Vr=0V, tp=10msec, Tvj=125C	I^2_t	500	A^2sec
Isolation test voltage	RMS, 50Hz, t=1min	V_{isol}	2500	V

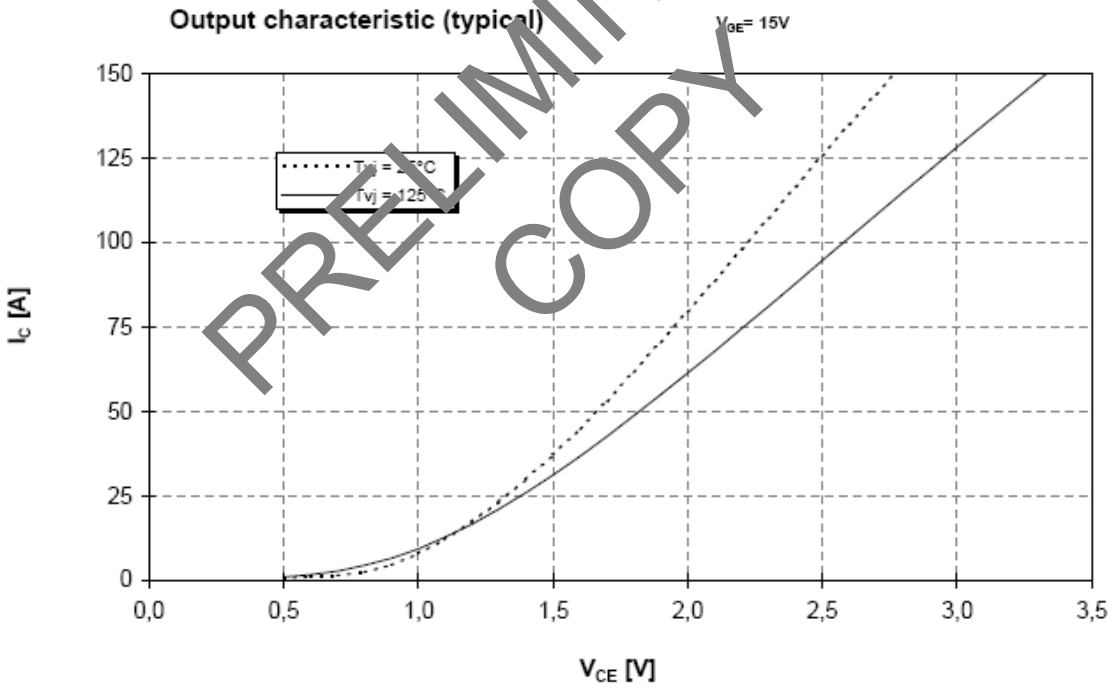
Collector-emitter saturation voltage	Ic=75A,Vge=15V, Tc=25C Ic=75A,Vge=15V,Tc=125C	$V_{ce(sat)}$		1.95 2.2	2.45	V
Gate Threshold voltage	Vce=Vge, Tvj=25C	$Vge_{(th)}$	4.5	5.5	6.5	V
Input capacitance	f=1MHz,Tvj=25C,Vce=25V, Vge=0V	C_{ies}		3.2		nF
Reverse transfer Capacitance	f=1MHz,Tvj=25C,Vce=25V, Vge=0V	C_{res}		0.3		nF
Collector emitter cut off current	Vce=600V,Vge=0V,Tvj=25C Vce=600V,Vge=0V,Tvj=125C	I_{ces}		1 1	500	µA
Gate emitter cut off current	Vce=0V,Vge=20V,Tvj=25C	I_{ges}			400	µA

Turn on delay time	Ic=75A, Vcc=300V Vge=+/15V,Rg=3Ω,Tvj=25C Vge=+/-15V,Rg=3Ω,Tvj=125C	$t_{d,on}$		63 65		nsec nsec
Rise time	Ic=75A, Vcc=300V Vge=+/-15V,Rg=3Ω,Tvj=25C Vge=+/-15V,Rg=3Ω,Tvj=125C	tr		22 1025		nsec nsec
Turn off delay time	Ic=75A, Vcc=300V Vge=+/-15V,Rg=3Ω,Tvj=25C Vge=+/-15V,Rg=3Ω,Tvj=125C	$t_{d,off}$		155 170		nsec nsec
Fall time	Ic=75A, Vcc=300V Vge=+/-15V,Rg=3Ω,Tvj=25C Vge=+/-15V,Rg=3Ω,Tvj=125C	t_f		20 35		nsec nsec
Turn energy loss per pulse	Ic=75A,Vce=300V,Vge=15V Rge=2.7Ω,Tvj=125C,L=35nH	E_{on}		0.7		mJ
Turn off energy loss per pulse	Ic=75A,Vce=300V, Vge=15V Rge=Ω,Tvj=125C,L=30nH	E_{off}		2.4		mJ
SC Data	tp≤10µsec, Vge≤15V Tvj≤125C, Vcc=300V,Vce(max)- Vces-Ldi/dt	I_{sc}		340		A
Stray Module inductance		$L_{\sigma ce}$		40		nH
Terminal-chip resistance		R_c		1.2		mΩ

Diode characteristics

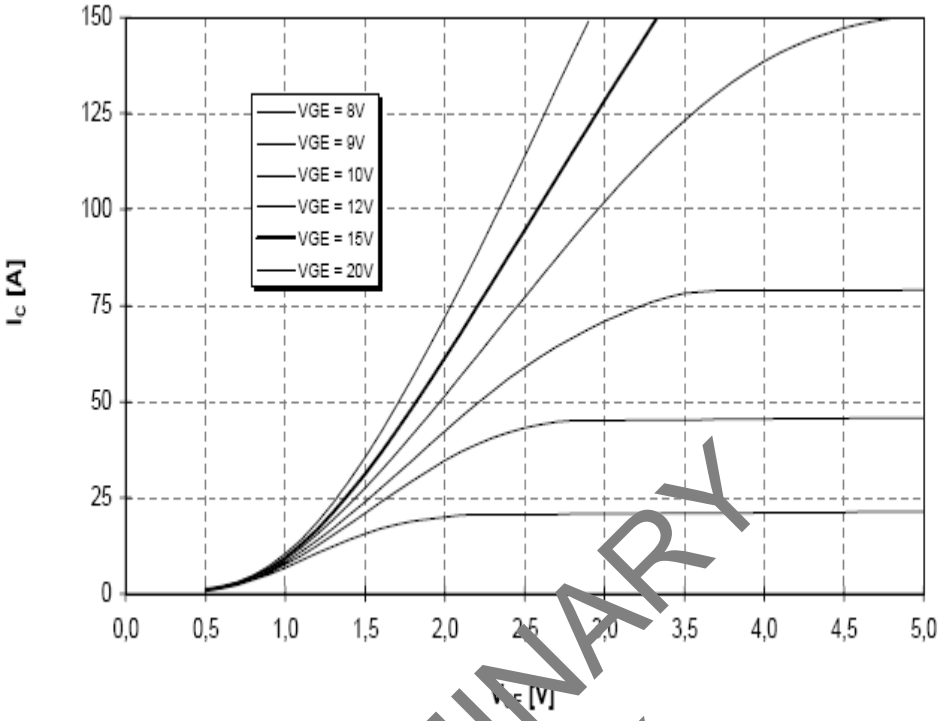
Forward voltage	Ic=75A,Vge=0V, Tc=25C Ic=75A,Vge=0V, Tc=125C	V_f		1.25 1.2	1.6	V
Peak reverse recovery current	If=75A, -di/dt=3000A/µsec Vce=300V,Vge=-10V,Tvj=25C Vce=300V,Vge=-10V,Tvj=125C	I_{rm}		95 115		A
Recovered charge	If=75A, -di/dt=3000A/µsec Vce=600V,Vge=-10V,Tvj=25C Vce=600V,Vge=-10V,Tvj=125C	Q_r		5.1 7.9		µC
Reverse recovery energy	If=75A, -di/dt=3000A/µsec Vce=600V,Vge=-10V,Tvj=25C Vce=600V,Vge=-10V,Tvj=125C	E_{rec}		. 2.3		mJ mJ

Thermal Properties			Min	Typ	Max	
Thermal resistance junction to case	Igbt Diode	$R_{\theta J-C}$			0.48 0.89	K/W
Thermal resistance case to heatsink		$R_{\theta C-hs}$		0.03		K/W
Maximum junction temperature		T_{vj}			150	C
Maximum operating temperature		T_{op}	-55		125	C
Storage Temperature		T_{stg}	-55		125	C



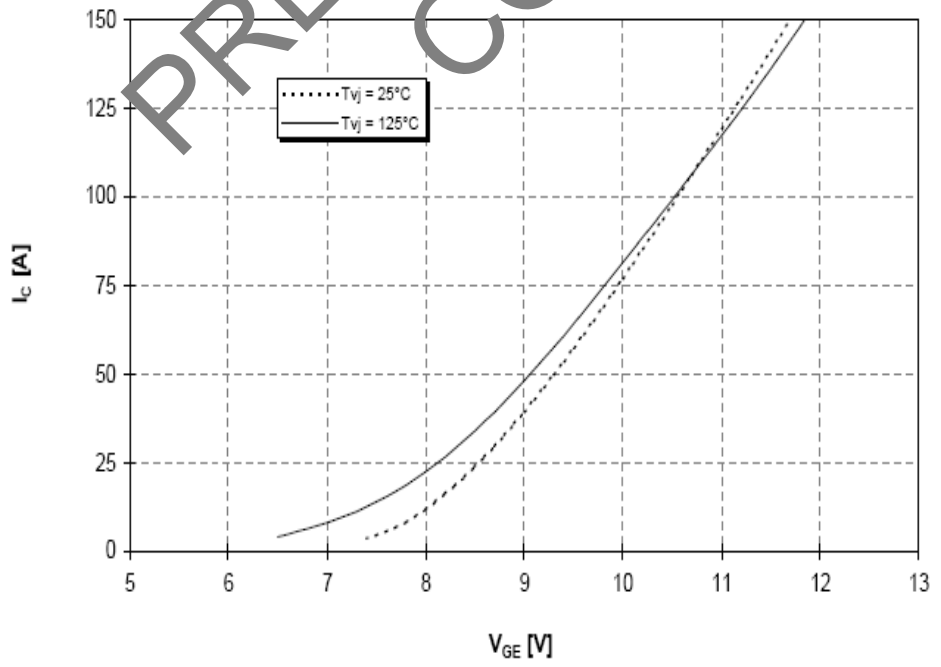
Output characteristic (typical)

T_{vj}= 125°C

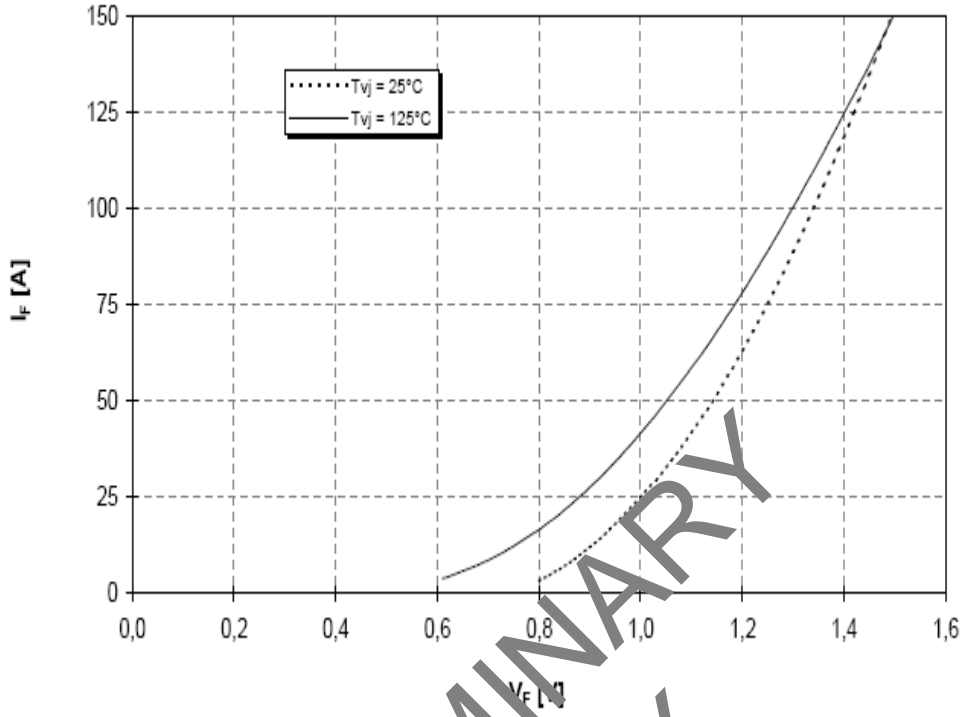


Transfer characteristic (typical)

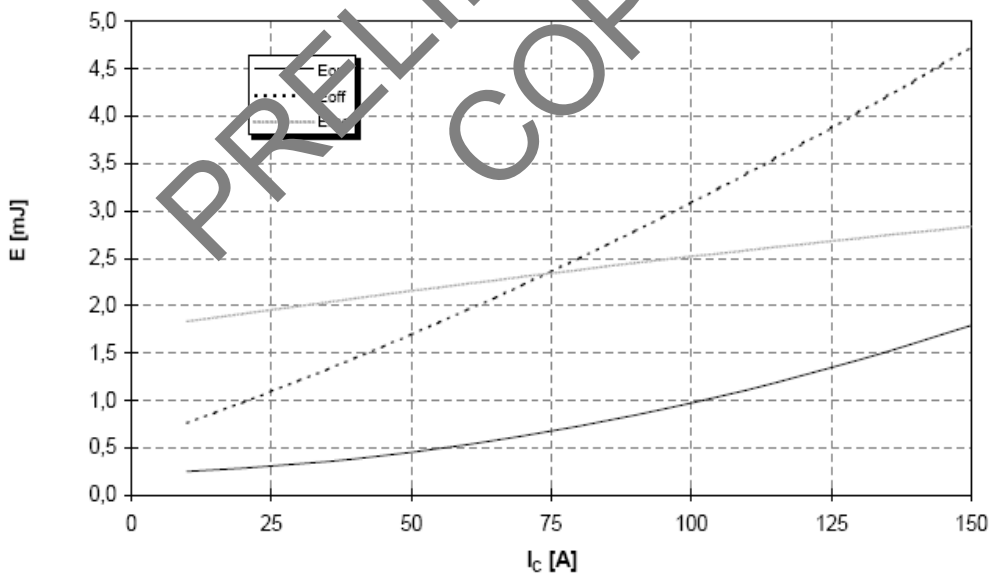
V_{CE}= 20V



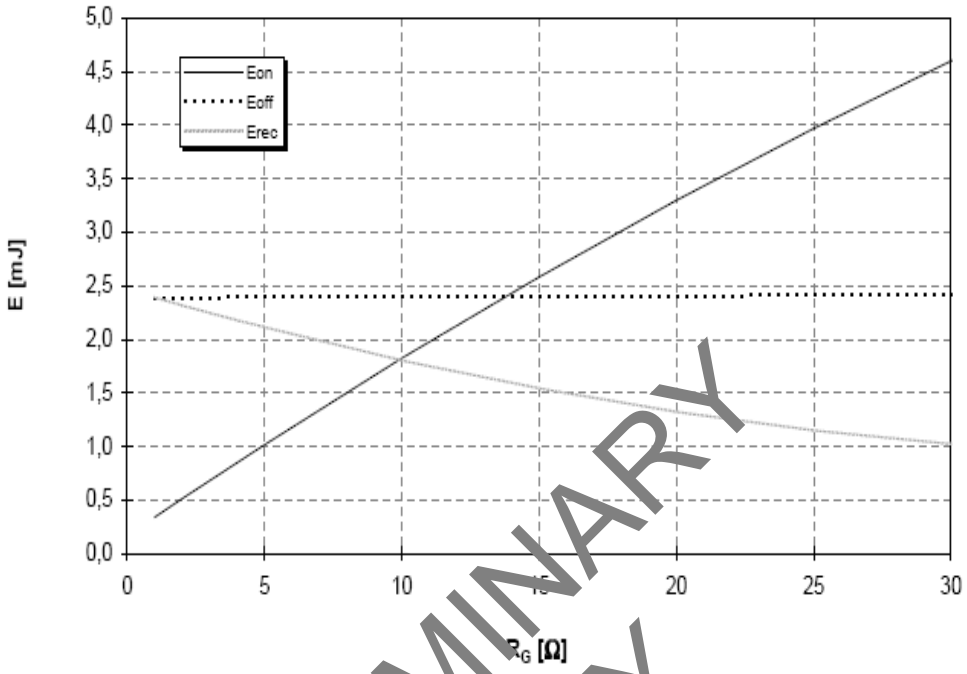
Forward characteristic of inverse diode (typical)



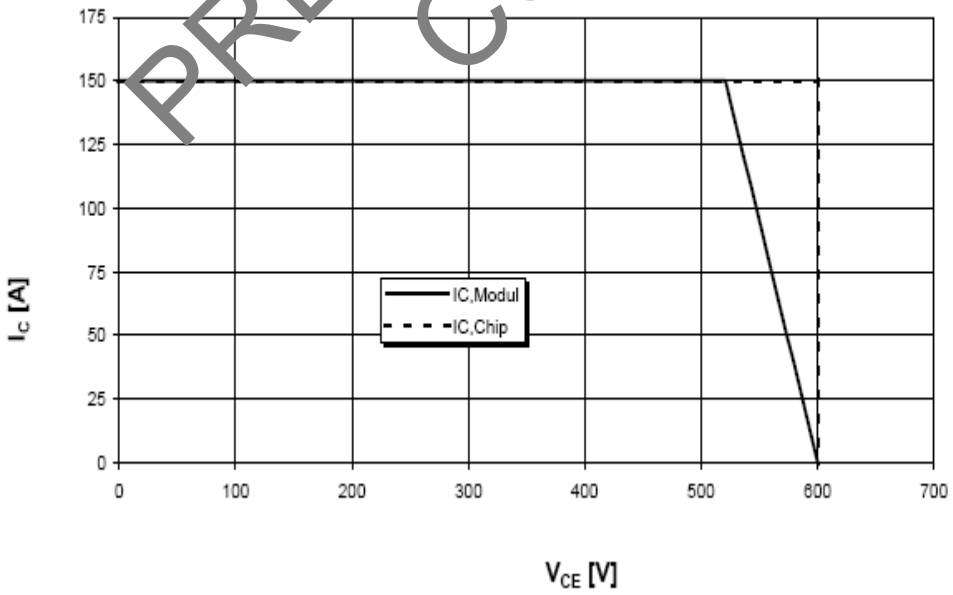
Switching losses (typical) $R_{G,on}$ = 3,0Ω, $R_{G,off}$ = 3,0Ω, V_{CC} = 300V, T_{vj} = 125°C



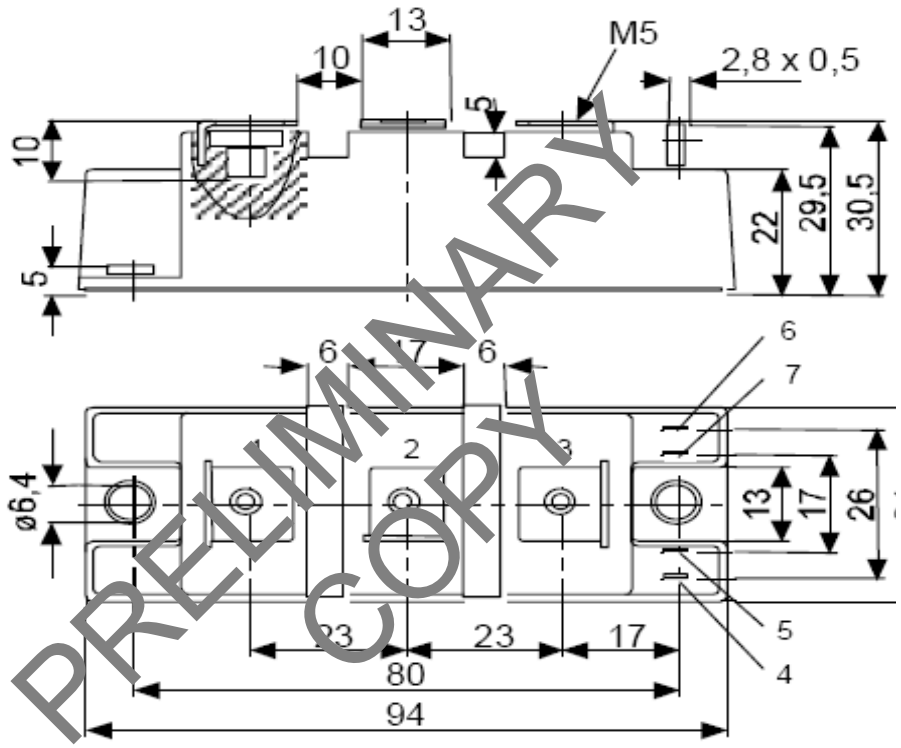
Switching losses (typical) I_C= 75A , V_{CC}= 300V , T_{vj} = 125°C

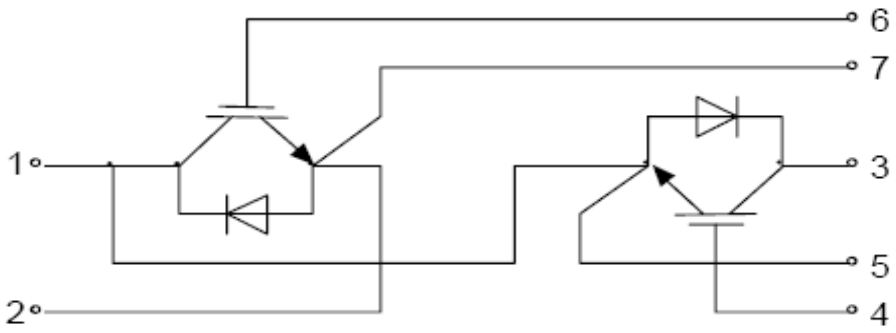


Reverse bias safe operation area (RBSOA) V_{GE}= +15V, $R_{G,off}$= 3,0Ω, T_{vj}= 125°C



Package outline / Circuit diagram





CIRCUIT DIAGRAM